

### **AUTOMOTIVE GRADE**

# AUIRFB4610 AUIRFS4610

HEXFET® Power MOSFET

### **Features**

- Advanced Process Technology
- Ultra Low On-Resistance
- Enhanced dV/dT and dI/dT capability
- 175°C Operating Temperature
- · Fast Switching

Description

· Repetitive Avalanche Allowed up to Timax

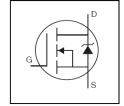
Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast

switching speed and improved repetitive avalanche rating. These

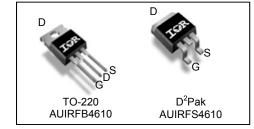
features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety

D<sup>2</sup>-Pak

- Lead-Free, RoHS Compliant
- Automotive Qualified \*



V <sub>DSS</sub>	100V
R <sub>DS(on)</sub> typ.	11mΩ
max.	14mΩ
I <sub>D</sub>	73A



G	D	S
Gate	Drain	Source

AUIRFS4610TRL

of other applications		•	Gate		Drain	Source
Daga naut numbar	Dookses Tyms	Standard Pack			Oudenshie Deut N	J
Base part number	Package Type	Form	rm Quantity		Orderable Part Number	
AUIRFB4610	TO-220	Tube	50		AUIRFB46	10
41.115.50.40.40	<b>5</b> 2 <b>5</b> .	Tube	50		AUIRFS46	10

800

### **Absolute Maximum Ratings**

AUIRFS4610

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Tape and Reel Left

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	73	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	52	Α
I <sub>DM</sub>	Pulsed Drain Current ①	290	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	190	W
	Linear Derating Factor	1.3	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) ②	370	mJ
I <sub>AR</sub>	Avalanche Current ①	See Fig.14,15, 22a, 22b	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ①		mJ
dv/dt	Peak Diode Recovery ③	7.6	V/ns
TJ	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		0.77	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50		°C/W
$R_{\theta JA}$	Junction-to-Ambient		62	C/VV
$R_{\theta JA}$	Junction-to-Ambient ( PCB Mount, steady state) ⑦		40	

HEXFET® is a registered trademark of Infineon.

2015-10-27

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<sup>\*</sup>Qualification standards can be found at www.infineon.com



# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.085	_	V/°C	Reference to 25°C, I <sub>D</sub> = 1mA ①
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		11	14	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 44A ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$ , $I_D = 100 \mu A$
gfs	Forward Trans conductance	73			S	$V_{DS} = 50V, I_{D} = 44A$
$R_G$	Gate Resistance		1.5		Ω	f = 1.0MHz, open drain
	Drain to Course Leekage Current			20		$V_{DS} = 100V, V_{GS} = 0V$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			250	μA	$V_{DS} = 100V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			200	A	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-200	nA	V <sub>GS</sub> = -20V

# Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

,	- J					
$Q_g$	Total Gate Charge		90	140		I <sub>D</sub> = 44A
$Q_{gs}$	Gate-to-Source Charge		20		nC	$V_{DS} = 80V$
$Q_{gd}$	Gate-to-Drain Charge		36			V <sub>GS</sub> = 10V4
t <sub>d(on)</sub>	Turn-On Delay Time		18			$V_{DD} = 65V$
t <sub>r</sub>	Rise Time		87		no	I <sub>D</sub> = 44A
t <sub>d(off)</sub>	Turn-Off Delay Time		53		ns	$R_G = 5.6\Omega$
t <sub>f</sub>	Fall Time		70			V <sub>GS</sub> = 10V4
C <sub>iss</sub>	Input Capacitance		3550			$V_{GS} = 0V$
Coss	Output Capacitance		260			V <sub>DS</sub> = 50V
C <sub>rss</sub>	Reverse Transfer Capacitance		150		pF	f = 1.0MHz, See Fig. 5
Coss eff.(ER)	Effective Output Capacitance (Energy Related)		330		-	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V $
Coss eff.(TR)	Effective Output Capacitance (Time Related)		380			$V_{GS}$ = 0V, $V_{DS}$ = 0V to 80V $\odot$

### **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions	
I <sub>S</sub>	Continuous Source Current (Body Diode)			73		MOSFET symbol showing the	
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ②			290	A	integral reverse p-n junction diode.	
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 44A, V_{GS} = 0V $ ④	
t <sub>rr</sub>	Reverse Recovery Time		35 42	53 63	ns	$T_J = 25^{\circ}C$ $V_{DD} = 85V$ $T_J = 125^{\circ}C$ $I_F = 44A$ ,	
Q <sub>rr</sub>	Reverse Recovery Charge		44 65	66 98	nC	$T_J = 25^{\circ}C$ di/dt = 100A/ $\mu$ s @	
I <sub>RRM</sub>	Reverse Recovery Current		2.1		Α	T <sub>J</sub> = 25°C	
t <sub>on</sub>	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ )				

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- $\odot$  Limited by  $T_{Jmax,}$  starting  $T_J$  = 25°C, L = 0.39mH,  $R_G$  = 25 $\Omega$ ,  $I_{AS}$  = 44A,  $V_{GS}$  =10V. Part not recommended for use above this value.
- $\label{eq:local_special} \mbox{ } \m$
- 4 Pulse width  $\leq 400 \mu s$ ; duty cycle  $\leq 2\%$ .
- $\circ$  Coss eff. (TR) is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 80% VDSS.
- $^{\circ}$  C<sub>oss</sub> eff. (ER) is a fixed capacitance that gives the same energy as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994



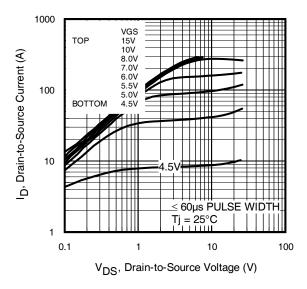


Fig. 1 Typical Output Characteristics

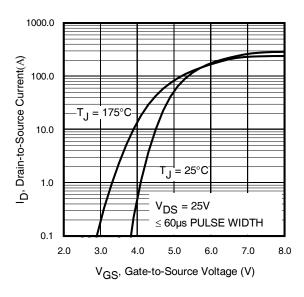


Fig. 3 Typical Transfer Characteristics

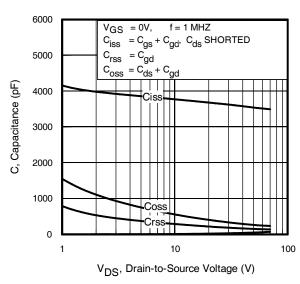


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

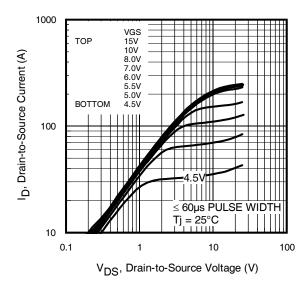


Fig. 2 Typical Output Characteristics

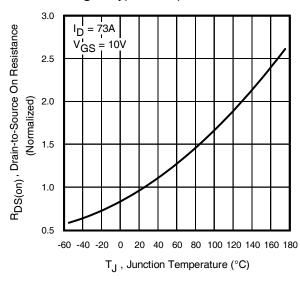


Fig. 4 Normalized On-Resistance vs. Temperature

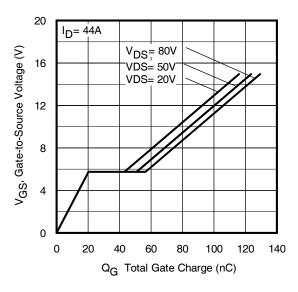


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



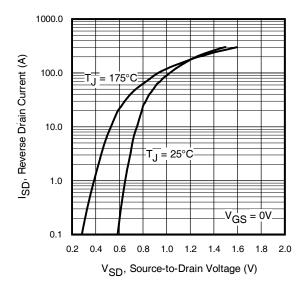
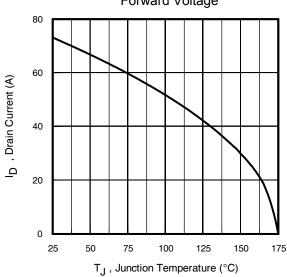


Fig. 7 Typical Source-to-Drain Diode Forward Voltage



Fg 9. Maximum Drain Current vs. Case Temperature

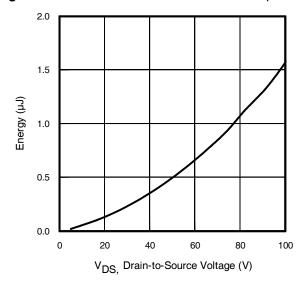


Fig 11. Typical Coss Stored Energy

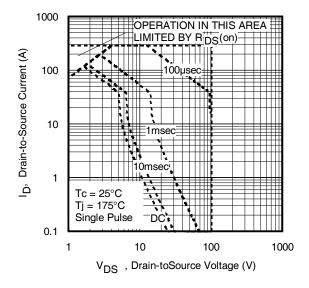


Fig 8. Maximum Safe Operating Area

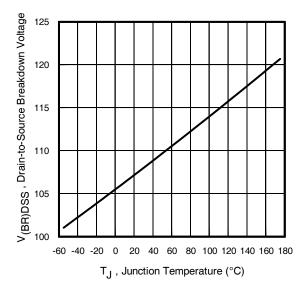


Fig 10. Drain-to-Source Breakdown Voltage

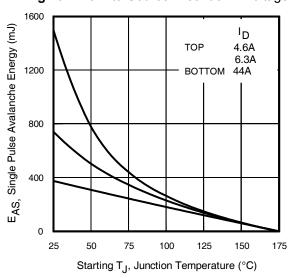


Fig 12. Maximum Avalanche Energy vs. Drain Current



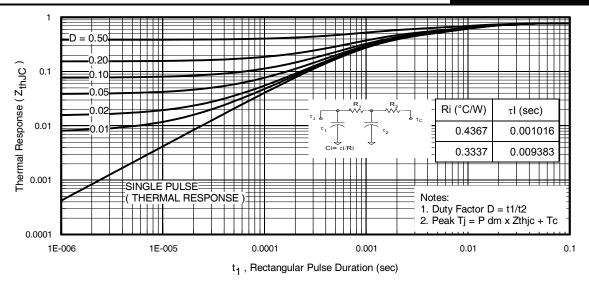


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

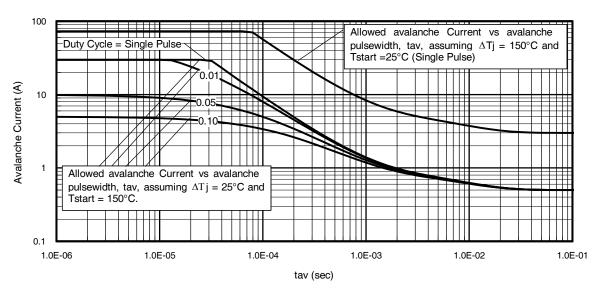
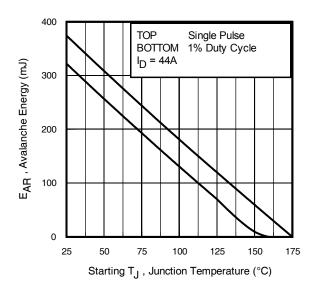


Fig 14. Avalanche Current vs. Pulse width



# Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
   Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>jmax</sub>. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T<sub>jmax</sub> is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 13, 14).

tav = Average time in avalanche.

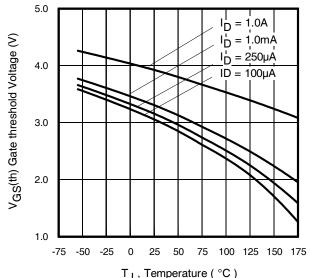
D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \text{ (ave)}} &= 1/2 \text{ ( } 1.3 \cdot BV \cdot I_{av}) = \Delta T / \text{ Z}_{thJC} \\ I_{av} &= 2\Delta T / \text{ [} 1.3 \cdot BV \cdot Z_{th} \text{]} \\ E_{AS \text{ (AR)}} &= P_{D \text{ (ave)}} \cdot t_{av} \end{split}$$

Fig 15. Maximum Avalanche Energy vs. Temperature





 $$T_J$$  , Temperature (  $^\circ\text{C}$  ) **Fig 16.** Threshold Voltage vs. Temperature

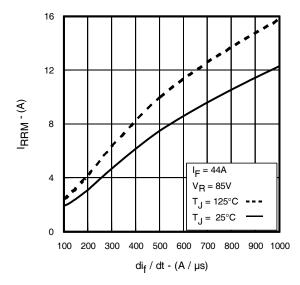


Fig. 18 - Typical Recovery Current vs. dif/dt

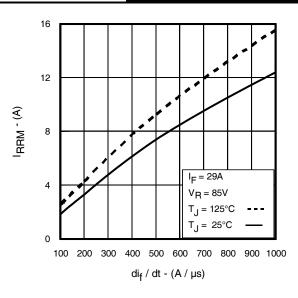


Fig. 17 - Typical Recovery Current vs. dif/dt

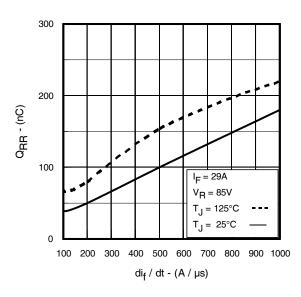


Fig. 19 - Typical Stored Charge vs. dif/dt

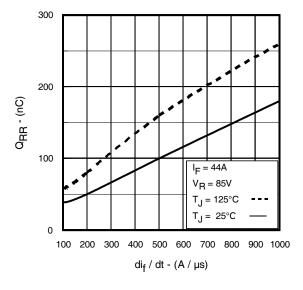


Fig. 20 - Typical Stored Charge vs. dif/dt



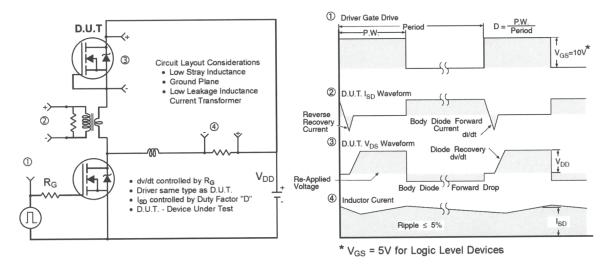


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

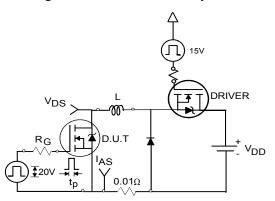


Fig 22a. Unclamped Inductive Test Circuit

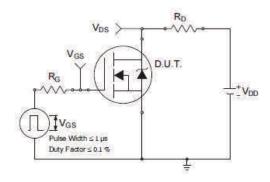


Fig 23a. Switching Time Test Circuit

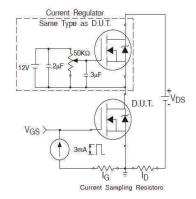


Fig 24a. Gate Charge Test Circuit

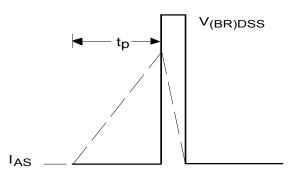


Fig 22b. Unclamped Inductive Waveforms

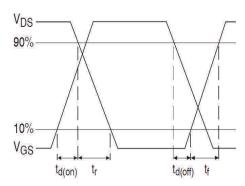


Fig 23b. Switching Time Waveforms

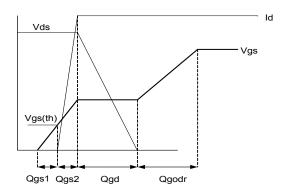
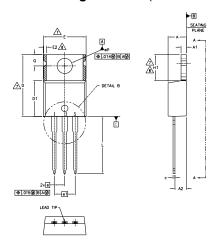
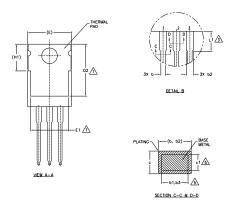


Fig 24b. Gate Charge Waveform



# TO-220AB Package Outline (Dimensions are shown in millimeters (inches))





### NOTES:

- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994. DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].
- LEAD DIMENSION AND FINISH UNCONTROLLED IN LT
- DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- DIMENSION 61, 63 & c1 APPLY TO BASE METAL ONLY.
- CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING
  AND SINGULATION IRREGULARITIES ARE ALLOWED.

  OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (mox.) AND D2 (min.)
  WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE.

	DIMENSIONS						
SYMBOL	MILLIMETERS INCHES						
	MIN.	MAX.	MIN.	MAX.	NOTES		
Α	3.56	4.83	.140	.190			
A1	1,14	1.40	.045	.055			
A2	2.03	2.92	.080	.115			
ь	0.38	1.01	.015	.040			
b1	0.38	0.97	.015	.038	5		
b2	1,14	1.78	.045	.070			
b3	1,14	1.73	.045	.068	5		
С	0.36	0.61	.014	.024			
c1	0.36	0.56	.014	.022	5		
D	14.22	16.51	.560	.650	4		
D1	8.38	9.02	.330	.355			
D2	11.68	12.88	.460	.507	7		
E	9.65	10.67	.380	.420	4,7		
E1	6.86	8.89	.270	.350	7		
E2	-	0.76	-	.030	8		
е	2.54		.100				
e1	5.08	BSC	.200	BSC			
H1	5.84	6.86	.230	.270	7,8		
L	12.70	14.73	.500	.580			
L1	3.56	4.06	.140	.160	3		
ØΡ	3.54	4.08	.139	.161			
Q	2.54	3.42	.100	.135			

#### LEAD ASSIGNMENTS

#### **HEXFET**

- 1.- GATE 2.- DRAIN 3.- SOURCE

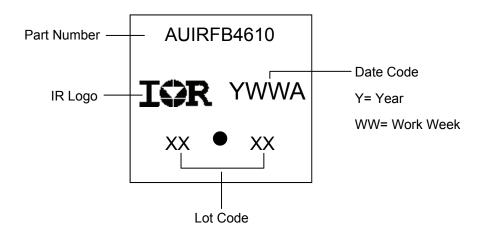
# IGBTs, CoPACK

- 1.- GATE 2.- COLLECTOR 3.- EMITTER

# DIODES

- 1.- ANODE 2.- CATHODE 3.- ANODE

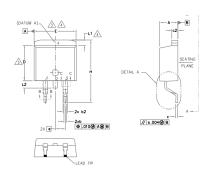
# **TO-220AB Part Marking Information**

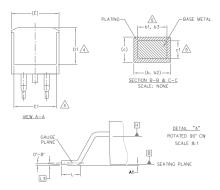


Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>



# D<sup>2</sup>Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S	DIMENSIONS						
M B	MILLIM	ETERS	INC	HES	NOTES		
O L	MIN.	MAX.	MIN.	MAX.	S		
А	4.06	4.83	.160	.190			
A1	0.00	0.254	.000	.010			
Ь	0.51	0.99	.020	.039			
ь1	0.51	0.89	.020	.035	5		
b2	1.14	1.78	.045	.070			
ь3	1.14	1.73	.045	.068	5		
С	0.38	0.74	.015	.029			
с1	0.38	0.58	.015	.023	5		
c2	1.14	1.65	.045	.065			
D	8.38	9.65	.330	.380	3		
D1	6.86	_	.270	_	4		
E	9.65	10.67	.380	.420	3,4		
E1	6.22	_	.245	_	4		
е	2.54	BSC	.100	BSC			
Н	14.61	15.88	.575	.625			
L	1.78	2.79	.070	.110			
L1	_	1.68	_	.066	4		
L2	_	1.78	_	.070			
L3	0.25	BSC	.010	BSC			

### LEAD ASSIGNMENTS

#### DIODES

1.— ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.— CATHODE 3.— ANODE

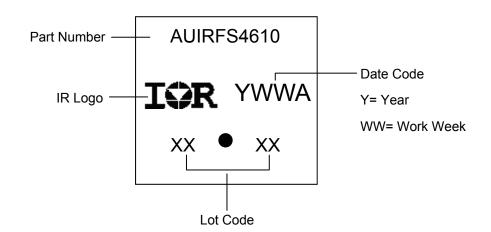
### HEXFET

IGBTs, CoPACK

# 1.- GATE 2, 4.- DRAIN 3.- SOURCE

1.- GATE 2, 4.- COLLECTOR 3.- EMITTER

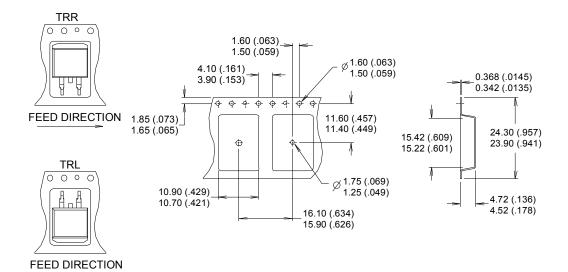
# D<sup>2</sup>Pak (TO-263AB) Part Marking Information

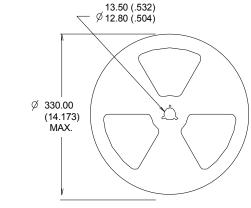


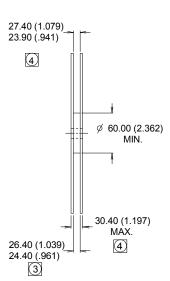
Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>



# D<sup>2</sup>Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))







NOTES:

- 1. COMFORMS TO EIA-418.
- 2. CONTROLLING DIMENSION: MILLIMETER.
- 🗷 DIMENSION MEASURED @ HUB.
- INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



### **Qualification Information**

ation. Infineon's				
on of the higher				
Automotive level.				
Class H1C (+/- 2000V) <sup>†</sup> AEC-Q101-001				
AEC-Q101-005				
Yes				

<sup>†</sup> Highest passing voltage.

## **Revision History**

Date	Comments
10/27/2015	Updated datasheet with corporate template
	Corrected ordering table on page 1.

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